

Polymer Enhanced Zener Diode Micro-Assemblies

PRODUCT: ZEN164V130A24LS

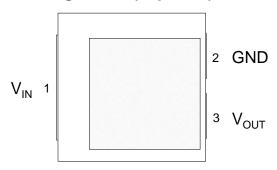
DOCUMENT: SCD27330 REV LETTER: D

REV DATE: JULY 26, 2016

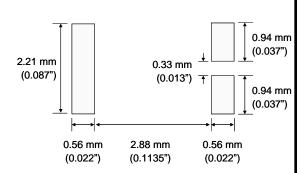
PAGE NO.: 2 OF 10

CONFIGURATION INFORMATION

Pin Configuration (Top View)



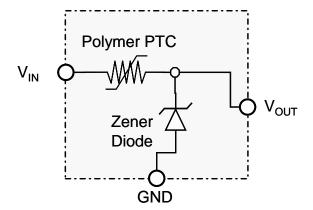
Recommended Pad Dimensions



PIN DESCRIPTION

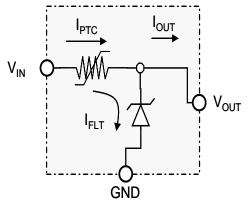
Pin Number	Pin Name	Pin Function
1	V _{IN}	V _{IN} . Protected input to Zener diode.
2	GND	GND
3	Vout	Vout. Zener regulated voltage output

BLOCK DIAGRAM



DEFINITION of TERMS

Іртс	Current flowing through the PTC portion of the circuit
I _{FLT}	RMS fault current flowing through the diode
Іоит	Current flowing out the Vout pin of the device
Trip Event	A condition where the PTC transitions to a high
	resistance state, thereby significantly limiting IPTC and related currents, and significantly increasing
	the voltage drop between V _{IN} and V _{OUT} .
Trip	Time the PTC portion of the device remains both
Endurance	powered and in a tripped state.





Polymer Enhanced Zener Diode Micro-Assemblies

PRODUCT: ZEN164V130A24LS

DOCUMENT: SCD27330 REV LETTER: D

REV DATE: JULY 26, 2016 PAGE NO.: 3 OF 10

GENERAL SPECIFICATIONS

Operating Temperature -40° to +85°C Storage Temperature -40° to +85°C

ELECTRICAL CHARACTERISTICS^{1-3, 11} (Typical unless otherwise specified)

	Vz ⁴ (V) I _{zt} I _{HOLD} Leakage Current		R Typ ⁶ R _{1Ma}	R _{1Max} ⁷	V _{Int} Max ⁸ (V)		I _{FLT} Max ⁹		Tripped Power Dissipation ¹⁰ Max					
Min	Тур	Max	(A)	[®] 20ºC (A)	Test Voltage	Max Current (mA)	(Ohms)	(Ohms)	V _{INT} Max (V)	Test Current (A)	I _{FLT} Max (A)	Test Voltage (V)	Value (W)	Test Voltage (V)
16.1	16.4	16.6	0.1	1.3	16	5	0.12	0.16	24V	ЗА	+1.25 -40	+24 -16V	1.0	24

- Note 1: Electrical characteristics determined at 25°C unless otherwise specified.
- Note 2: This device is intended for limited fault protection. Repeated trip events or extended trip endurance can degrade the device and may affect performance to specifications. Performance impact will depend on multiple factors including, but not limited to, voltage, trip current, trip duration, trip cycles, and circuit design. For details or ratings specific to your application contact Littelfuse Circuit Protection directly.
- Note 3: Specifications developed using 1.0 ounce 0.045" wide copper traces on dedicated FR4 test boards. Performance in your application may vary.
- Note 4: I_{zt} is the current at which V_z is measured ($V_z = V_{OUT}$). Additional V_z values are available on request.
- Note 5: IHOLD: Maximum steady state IPTC (current entering or exiting the VIN pin of the device) that will not generate a trip event at the specified temperature. Specification assumes IFLT (current flowing through the Zener diode) is sufficiently low so as to prevent the diode from acting as a heat source. Testing is conducted with an "open" Zener.
- Note 6: R Typ: Resistance between V_{IN} and V_{OUT} pins during normal operation at room temperature.
- Note 7: R_{1Max}: The maximum resistance between V_{IN} and V_{OUT} pins at room temperature, one hour after 1st trip or after reflow soldering.
- Note 8: VINT Max: VINT Max relates to the voltage across the PPTC portion of the PolyZen device (VIN-VOUT). VINT Max is defined as the voltage (VIN-VOUT) at which typical qualification devices (98% devices, 95% confidence) survived at least 100 trip cycles and 24 hours trip endurance at the specified voltage (VIN-VOUT) and current (IPTC). VINT Max testing is conducted using a "shorted" load (VOUT = 0V). VINT Max is a survivability rating, not a performance rating.
- Note 9: IFLT Max: IFLT Max relates to the stead state current flowing through the diode portion of the PolyZen device in a fault condition, prior to a trip event. IFLT Max is defined as the current at which typical qualification devices (12 parts per lot from 3 lots) survived 100 test cycles. RMS fault currents above IFLT Max may permanently damage the diode portion of the PolyZen device. Testing is conducted with NO load connected to Vout, such that Iout = 0. "Test voltage" is defined as the voltage between VIN to GND and includes the PolyZen Diode drop. Specification is dependent on the direction of current flow through the diode. IFLT Max is a survivability rating, not a performance rating.
- Note 10: The power dissipated by the device when in the "tripped" state, as measured on Littelfuse test boards (see note 3).
- Note 11: Specifications based on limited qualification data and subject to change.



PolyZenPolymer Enhanced Zener Diode **Micro-Assemblies**

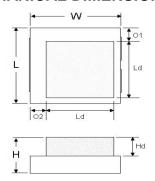
PRODUCT: ZEN164V130A24LS

DOCUMENT: SCD27330 REV LETTER: D

REV DATE: JULY 26, 2016

PAGE NO.: 4 OF 10

MECHANICAL DIMENSIONS



		Min	Typical	Max
Length	1	3.85 mm	4 mm	4.15 mm
Longin	_	(0.152")	(0.16")	(0.163")
Width	W	3.85 mm	4 mm	4.15 mm
VVIGUI	• • •	(0.152")	(0.16")	(0.163")
Height	Н	1.4mm	1.7 mm	2.0 mm
Height	''	(0.055")	(0.067")	(0.081")
Length	Ld		3.0 mm	
Diode	Lu	-	(0.118")	-
Height	Hd		1.0 mm	
Diode	l lu	-	(0.039")	-
Offset	01		0.6 mm	
Oliset	01	-	(0.024")	-
Offset	02		0.7 mm	
Oilset	O2	-	(0.028")	-

SOLDER REFLOW RECOMMENDATIONS:

Classification Reflow Profiles	
Profile Feature	Pb-Free Assembly
Average Ramp-Up Rate (Tsmax to Tp)	3° C/second max.
Preheat	
 Temperature Min (Tsmin) 	150 °C
 Temperature Max (Tsmax) 	200 °C
Time (tsmin to tsmax)	60-180 seconds
Time maintained above:	
Temperature (TL)	217 °C
• Time (tL)	60-150 seconds
Peak/Classification Temperature	
(Tp)	260 °C
Time within 5 °C of actual Peak	
Temperature (tp)	20-40 seconds
Ramp-Down Rate	6 °C/second max.
Time 25 °C to Peak Temperature	8 minutes max.



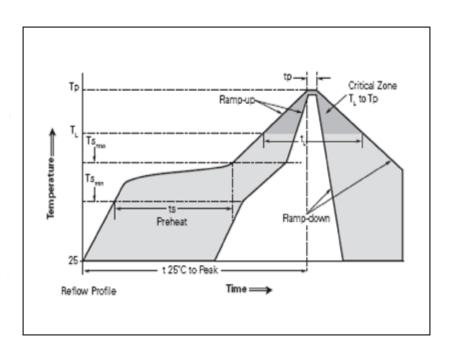
PolyZenPolymer Enhanced Zener Diode **Micro-Assemblies**

PRODUCT: ZEN164V130A24LS

DOCUMENT: SCD27330 REV LETTER: D

REV DATE: JULY 26, 2016

PAGE NO.: 5 OF 10



PACKAGING

Packaging	Tape & Reel	Standard Box
ZENXXXVXXXAXXLS	3,000	15,000

Reel Dimensions for PolyZen Devices

	$A_{\text{max}} = 330$
	$N_{min} = 102$
,	$W_1 = 8.4$
	$W_2 = 11.1$



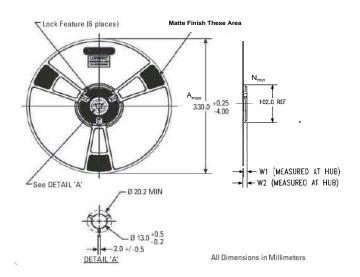
Polymer Enhanced Zener Diode **Micro-Assemblies**

PRODUCT: ZEN164V130A24LS

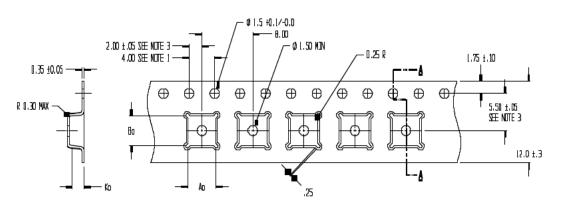
DOCUMENT: SCD27330 REV LETTER: D

REV DATE: JULY 26, 2016

PAGE NO.: 6 OF 10



Taped Component Dimensions for PolyZen Devices



NOTES:

1. 10 SPROCKET HOLE PITCH CLMULATIVE TOLERANCE ±0.2 4a = 4.35

2. CAMBER IN COMPLIANCE VITH EIA 481

Ba = 4.35 Ka = 2.30 3. POCKET POSITION RELATIVE TO SPROCKET HOLE MEASURED AS TRUE POSITION OF POOKET, NOT POCKET HOLE



Polymer Enhanced Zener Diode Micro-Assemblies

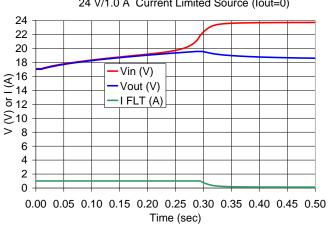
PRODUCT: ZEN164V130A24LS

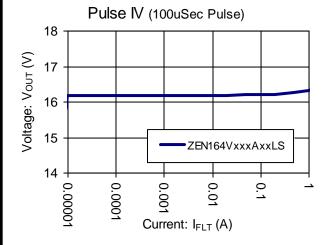
DOCUMENT: SCD27330 REV LETTER: D

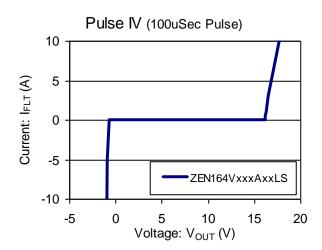
REV DATE: JULY 26, 2016 PAGE NO.: 7 OF 10

TYPICAL CHARACTERISTICS

Typical Fault Response: ZEN164V130A24LS 24 V/1.0 A Current Limited Source (lout=0)







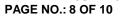


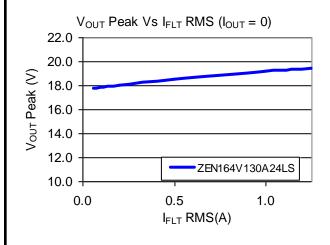
Polymer Enhanced Zener Diode Micro-Assemblies

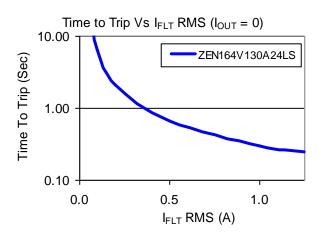
PRODUCT: ZEN164V130A24LS

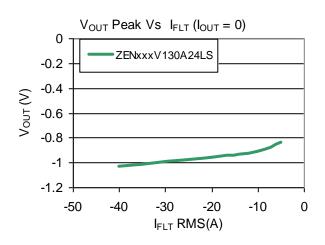
DOCUMENT: SCD27330 REV LETTER: D

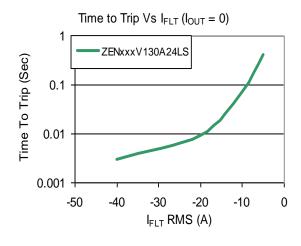
REV DATE: JULY 26, 2016

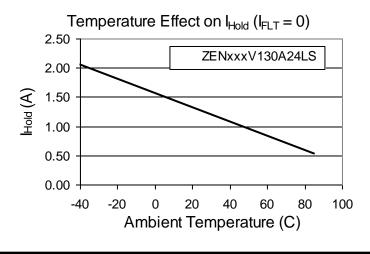


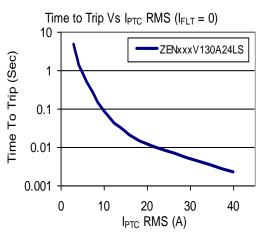














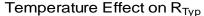
Polymer Enhanced Zener Diode Micro-Assemblies

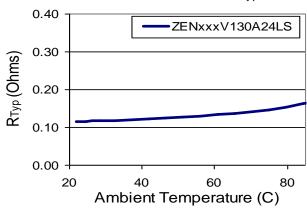
PRODUCT: ZEN164V130A24LS

DOCUMENT: SCD27330 REV LETTER: D

REV DATE: JULY 26, 2016

PAGE NO.: 9 OF 10





Materials Information

ROHS Compliant

Directive 2002/95/EC Compliant **ELV Compliant**

Directive 2000/53/EC Compliant **Pb-Free**



Halogen Free*



* Halogen Free refers to: Br≤900ppm, Cl≤900ppm, Br+Cl≤1500ppm.

Littlefuse products are not designed for, and shall not be used for, any purpose (including, without limitation, automotive, military, aerospace, medical, life-saving, life-sustaining or nuclear facility applications, devices intended for surgical implant into the body, or any other application in which the failure or lack of desired operation of the product may result in personal injury, death, or property damage) other than those expressly set forth in applicable Littlefuse product documentation. Warranties granted by Littlefuse shall be deemed void for products used for any purpose not expressly set forth in applicable Littlefuse documentation. Littlefuse shall not be liable for any claims or damages arising out of products used in applications not expressly intended by Littlefuse as set forth in applicable Littlefuse documentation. The sale and use of Littlefuse products is subject to Littlefuse Terms and Conditions of Sale, unless otherwise agreed by Littlefuse